NVL Laboratories, Inc.

Analysis Report Polychlorinated Biphenyls (PCBs)



Client: NVL Laboratories, Inc.

Address: 4708 Aurora Ave N

Seattle, WA 98103

Attention: Mr. Munaf Khan

Project Location: 3100 Airport Way South

Seattle, WA 98134

NVL Batch No. 1418209.00

Method No. EPA 8082

Client Project # 2012-494

Date Received: 10/13/2014

Matrix: Wipe

Samples Received: 4

Samples Analyzed: 4

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Lab Sample ID:	14129924	14129925	14129926	14129927	
Client Sample ID:	101314-WIPE-1	101314-WIPE-2	101314-WIPE-3	101314-WIPE-4	
Sample Description:	Building 13, N Side, NW Corner	Building 13, NW Corner	Building 13, W Side, NW Corner	Field Blank	
Sample Area (cm2)	100.0	100.0	100.0	0.0	
РСВ Туре	ug/100 cm2	ug/100 cm2	ug/100 cm2	ug/100 cm2	
Aroclor 1016	ND	ND	ND	NA	
Aroclor 1221	ND	ND	ND	NA	
Aroclor 1232	ND	ND	ND	NA	
Aroclor 1242	ND	ND	ND	NA	
Aroclor 1248	ND	ND	ND	NA	
Aroclor 1254	0.7	0.1	0.4	NA	
Aroclor 1260	0.2	0.1	0.5	NA	
Total: PCB Concentration	0.9	0.2	0.9	NA	
Reporting Limit (RL) :	2.0	2.0	2.0	<2.0	

Remarks: ug/100 cm2 = Micrograms per 100 square centimeter

Sample area based on cm2 per wipe

ND = None Detected (<RL)

<RL = Below the reporting limit of instrument

Sampled by: Client

Analyzed by: Evelyn Ahulu

Analysis Date: 10/13/2014

Reviewed by: Nick Ly

Reviewed Date: 10/13/2014

Nick Ly, Technical Director

Preparation and analysis of these samples were conducted in accordance with published test methods. Unless stated otherwise, the condition of all samples was acceptable at time of receipt. Reported sample results are based on dry weight and method QC results are acceptable unless stated otherwise. If samples were not collected by NVL personnel, then the accuracy of the results is limited by the methodology and acuity of the sample collector. This report shall not be reproduced except in full, without written approval of NVL Laboratories, Inc.. Responsibility for Interpretation of the reported data rests with the client.

NVL Laboratories, Inc. 4708 Aurora Ave N, Seattle, WA 98103 Tel: 206.547.0100 Emerg. Cell: 206.914.4646 1.888.NVL.LABS (685.5227) www.nvllabs.com

CHAIN of CUSTODY SAMPLE LOG



1418209

	Client 1	nt NVL Laboratories Inc				NVL Batch Number						
	Street 4	eet 4708 Aurora Ave N			Cli	Client Job Number 2012-494						
	-	Seattle, WA 98103					Total Samples	4				
Project M	anager I	er Munaf Khan				Tu	ırn Around Time	= =	Hrs 🗌 2	<u> </u>		
		ation 3100 Airport Way South				☐ 2-Hrs ☐ 12 ☐ 4-Hrs 🟋 24	-Hrs	☐ 6-10)			
,	5	Seattle, V	VA 981	34						for TAT less that	an 24 Hrs	
	=							Email address				
Phone: (206) 447-0263 Fax: (206) 447-0299												
Asbestos Air PCM (NIOSH 7400) TEM (NIOSH 7402) TEM (AHERA) TEM (EPA Level II) Other												
Asbestos Bulk PLM (EPA/600/R-93/116) PLM (EPA Point Count) PLM (EPA Gravimetry) TEM BULK												
Mold/Fungus Mold Air Mold Bulk Rotometer Calibration												
☐ TCLF	Metals	☐ ICP ☐ GFA	nit (ppm) (ppm) A (ppb)	☐ Dust/\	iter ing water wipe (Are	ea) 🗌 Paint	Chips Chips	\	(As) Chro Ba) Lead n (Cd) Merc	omium (C d (Pb) cury (Hg)	her Meta All 3 Copper ((Nickel (N Zinc (Zn)	Cu)
	alysis	Silica	_	=	ahle Dus		(Opcon	77.100				•
Conditio	n of Pacl	cage: 🗌	Good	🗌 Damaç	ged (no s	pillage)	Severe	damage (spillag	e)	49		
Seq. #	Lab ID		Clien	t Sample	Number	Comments	.			V	AREA	¥/R
1			101314	1-WIPE	E -1	BULLDIA	56	13, NS	IDE, NW	LORNER	100 cm2	
2					2	BULCOIN	6	13 NW C	orner			
3					3	BULLDIN		13, W 5	IDE, NW	CORNER	+	
4					4	FIELD	B	NANK	•			
5)		
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	nalyzed b	- 1	1/1	the	4	Stan	l		TAL	10/13/14	. 15:3	o
	Called b	-							***************************************			
	s Faxed b											
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	report to	.ioiia. Uľ	1509 IEC	Incoren IU	i wilulig,	an samples v	viii De û	ishosea oi two (S	, weeks aller all	aiyəiə.		